EPMA Workshop

9:45 - 10:15: Welcome and registration of guests

- **10:15 10:20: Opening** by G. Lathus
- 10:20 10:45: History of JEOL EPMA and Introduction to our New EPMA by R. Wakimoto
- 10:45 11:10: JXA-iHP200F: applications in Geosciences at ISTerre microanalytical platform by <u>A. Sobolev</u>, V. Batanova and V. Magnin
- 11:10 11:35: Introduction and current development status of JEOL soft X-ray emission spectrometer

by S. Koshiya

 11:35 – 12:00: Quartz reworking during experimental deformation of quartz-mica assemblages revealed by hyperspectral cathodoluminescence by <u>G. Wille</u>, <u>K. Alaoui</u>

12:00 – 13:30: Lunch buffet

- 13:30 14:50: Laboratory visit by G. Lathus
- 14:00 14:25: Gather X: New EDS generation by Y. Uetake
- 14:25 14:50: EPMA and GDOES, complementary analysis techniques by B. Remy
- 14:50 15:15: Améliorer ses préparations avec le Cross Polisher JEOL by S. Rajendirane
- 15:15 15:40: Evaluation of SXES on ceramic materials : successes and failures by J-L. Longuet
- 15:40 16:00: Service JEOL : parc et ressources by B. Hermann
- 16:00: Closing by G. Lathus





